

Notice of References Cited

Application/Control No.

09/855,723

Applicant(s)/Patent Under

Reexamination

NAKANO ET AL.

Examiner

Magid Y Dimyan

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,634,008 ,	10-2003	Dole, Harry	716/1
	B	US-5,570,291 ,	10-1996	Dudle et al.	700/95
	C	US-6,594,799 ,	07-2003	Robertson et al.	716/1
	D	US-6,487,469 ,	11-2002	Formenti, Jose Antonio Vieira	700/97
	E	US-6,366,874 ,	04-2002	Lee et al.	703/14
	F	US-5,778,386 ,	07-1998	Lin et al.	707/10
	G	US-2002/0013634 , ,	01-2002	Lee, Jae Kyung	700/97
	H	US-5,878,408 ,	03-1999	Van Huben et al.	707/1
	I	US-2002/0023329 , ,	02-2002	Nulman, Jaim	29/25.01
	J	US-6,578,188 ,	06-2003	Pang et al.	716/19
	K	US-6,269,467 ,	07-2001	Chang et al.	716/1
	L	US-2002/0078422 ,	06-2002	Bradley et al.	716/1
	M	US-6,456,894 ,	09-2002	Nulman, Jaim	700/121

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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